









SN74AHCT1G86

JAJSOZ8P - MARCH 1996 - REVISED FEBRUARY 2024

SN74AHCT1G86 シングル 2 入力排他 OR ゲート

1 特長

- 動作範囲:4.5V~5.5V
- 最大 t_{nd}:8ns (5V 時)
- 低消費電力、I_{CC}の最大値 10A
- 5V で 8mA の出力駆動能力
- 入力は TTL 電圧互換
- JESD 17 準拠で 250mA 超のラッチアップ性能

2 アプリケーション

- 産業用 PC
- ステッピング・モーター
- AC インバータ・ドライブ
- ノート PC
- スマート・メーター:データ・コンセントレータ
- エンタープライズ・サーバー

3 概要

SN74AHCT1G86 はシングル 2 入力排他 OR ゲートで す。ブール関数 $Y = A \oplus B$ 、つまり $Y = \overline{A}B + A\overline{B}$ を正論 理で実行します。

パッケージ情報

部品番号	部品番号 パッケージ (1)		本体サイズ ⁽³⁾
SN74AHCT1G86	DBV (SOT-23, 5)	2.90mm × 2.8mm	2.9mm × 1.6mm
31174/11/01 1900	DCK (SC-70, 5)	2.00mm × 1.25mm	2.00mm × 1.25mm

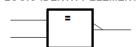
- 詳細については、セクション 11 を参照してください。 (1)
- パッケージ サイズ (長さ×幅) は公称値で、該当する場合はピンも 含まれます。
- 本体サイズ (長さ×幅) は公称値であり、ピンは含まれません。

An exclusive-OR gate has many applications, some of which can be represented better by alternative logic symbols.



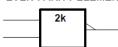
These five equivalent exclusive-OR symbols are valid for an SN74AHCT1G86 gate in positive logic; negation may be shown at any two ports.

LOGIC-IDENTITY ELEMENT



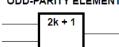
The output is active (low) if all inputs stand at the same logic level (i.e., A = B).

EVEN-PARITY ELEMENT



The output is active (low) if an even number of inputs (i.e., 0 or 2) are active.

ODD-PARITY ELEMENT



The output is active (high) if an odd number of inputs (i.e., only 1 of the 2) are active.

排他 OR ロジック



Table of Contents

1 特長	1	7.3 Feature Description	8
2 アプリケーション		7.4 Device Functional Modes	
3 概要		8 Application and Implementation	9
4 Pin Configuration and Functions		8.1 Application Information	9
5 Specifications		8.2 Typical Application	9
5.1 Absolute Maximum Ratings		8.3 Power Supply Recommendations	11
5.2 ESD Ratings		8.4 Layout	11
5.3 Recommended Operating Conditions		9 Device and Documentation Support	12
5.4 Thermal Information		9.1 Documentation Support	12
5.5 Electrical Characteristics	5	9.2ドキュメントの更新通知を受け取る方法	12
5.6 Switching Characteristics		9.3 サポート・リソース	12
5.7 Operating Characteristics		9.4 Trademarks	
5.8 Typical Characteristics		9.5 静電気放電に関する注意事項	12
6 Parameter Measurement Information		9.6 用語集	
7 Detailed Description	8	10 Revision History	
7.1 Overview		11 Mechanical, Packaging, and Orderable	
7.2 Functional Block Diagram		Information	13

English Data Sheet: SCLS324



4 Pin Configuration and Functions

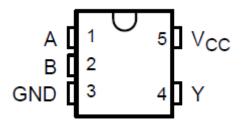


図 4-1. DBV or DCK Package 5-Pin SOT-23 Top View

P	PIN	TYPE ⁽¹⁾	DESCRIPTION				
NO.	NAME	ITPE\"	DESCRIPTION				
1	Α	I	A input				
2	В	I	B input				
3	GND	_	Ground pin				
4	Y	0	Output				
5	V _{CC}	_	Power pin				

(1) Signal Types: I = Input, O = Output, I/O = Input or Output

3

Product Folder Links: SN74AHCT1G86



5 Specifications

5.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted) (1)

			MIN	MAX	UNIT
V _{CC}	Supply voltage		-0.5	7	V
VI	Input voltage ⁽²⁾	-0.5	7	V	
Vo	Output voltage ⁽²⁾	-0.5	V _{CC} + 0.5	V	
I _{IK}	Input clamp current	V ₁ < 0		-20	mA
I _{OK}	Output clamp current	$V_O < 0$ or $V_O > V_{CC}$	-20	20	mA
Io	Continuous output current	$V_O = 0$ to V_{CC}	-25	25	mA
	Continuous current through V _{CC} or GND	·	-50	50	mA
T _{stg}	Storage temperature		-65	150	°C
T _J	Junction Temperature			150	°C

⁽¹⁾ Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

5.2 ESD Ratings

			VALUE	UNIT
		Human body model (HBM), per ANSI/ESDA/JEDEC JS-001 ⁽¹⁾	±2000	
V _(ESD)	Electrostatic discharge	Charged-device model (CDM), per JEDEC specification JESD22-C101 ⁽²⁾	±1000	V

⁽¹⁾ JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

5.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

		MIN	NOM MAX	UNIT
V _{CC}	Supply voltage	4.5	5.5	V
V _{IH}	High-level input voltage	2		V
V _{IL}	Low-level input voltage		0.8	V
VI	Input voltage	0	5.5	V
Vo	Output voltage	0	V _{CC}	V
I _{OH}	High-level output current		-8	mA
I _{OL}	Low-level output current		8	mA
t/v	Input transition rise or fall rate		20	ns/V
T _A	Operating free-air temperature	-40	125	°C

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⁽²⁾ The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

⁽²⁾ JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

5.4 Thermal Information

		SN74AH	SN74AHCT1G86			
	THERMAL METRIC ⁽¹⁾	DBV (SOT-23)	DCK (SC-70)	UNIT		
		5 PINS	5 PINS			
R _{0JA}	Junction-to-ambient thermal resistance	278	289.2			
R _{0JC(top)}	Junction-to-case (top) thermal resistance	180.5	205.8			
$R_{\theta JB}$	Junction-to-board thermal resistance	184.4	176.2	°C/W		
ΨЈТ	Junction-to-top characterization parameter	115.4	117.6	C/VV		
ΨЈВ	Junction-to-board characterization parameter	183.4	175.1			
$R_{\theta JC(bot)}$	Junction-to-case (bot) thermal resistance	N/A	N/A			

⁽¹⁾ For more information about traditional and new thermal metrics, see the IC Package Thermal Metrics application report (SPRA953).

5.5 Electrical Characteristics

over operating free-air temperature range (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	v	Т,	₄ = 25°C		-40°C to 85°C		-40°C to 125°C		UNIT
	FARAWIETER	TEST CONDITIONS	V _{cc}	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNII
V	High level output	I _{OH} = -50 μA	4.5 V	4.4	4.5		4.4		4.4		V
V _{OH}	voltage	I _{OH} = -8 mA	4.5 V	3.94			3.8		3.8		V
V	Low level output	I _{OL} = 50 μA	4.5 V			0.1		0.1		0.1	V
V _{OL}	voltage	I _{OL} = 8 mA	4.5 V			0.36		0.44		0.44	V
I	Input leakage current	V _I = 5.5 V or GND	0 V to 5.5 V			±0.1		±1		±1	μΑ
I _{CC}	Supply current	V _I = V _{CC} or GND, I _O = 0	5.5 V			1		10		10	μА
ΔI _{CC} (1)	Supply-current change	One input at 3.4 V, Other inputs at V _{CC} or GND	5.5 V			1.35		1.5		1.5	mA
Ci	Input capacitance	V _I = V _{CC} or GND	5 V		2	10		10		10	pF

⁽¹⁾ This is the increase in supply current for each input at one of the specified TTL voltage levels, rather than 0 V or V_{CC}.

5.6 Switching Characteristics

over recommended operating free-air temperature range, V_{CC} = 5 V ± 0.5 V (unless otherwise noted) (see Load Circuit and Voltage Waveforms)

PARAMETER	FROM	то	LOAD	T _A = 25	°C	-40°C to	85°C	-40°C to	125°C	UNIT
	(INPUT)	(OUTPUT)	CAPACITANCE	TYP	MAX	MIN	MAX	MIN	MAX	UNII
t _{PLH}	A or B	~	C ₁ = 15 pF	5	6.2	1	8	1	9	ne
t _{PHL}	AOIB	ī	C _L = 15 pr	5	6.2	1	8	1	9	ns
t _{PLH}	A or B	V	C ₁ = 50 pF	5.5	7.9	1	9	1	10	20
t _{PHL}		ī	O _L = 50 pF	5.5	7.9	1	9	1	10	ns

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5



5.7 Operating Characteristics

 V_{CC} = 5 V, T_A = 25°C

	PARAMETER	TEST (CONDITIONS	TYP	UNIT
C _{pd}	Power dissipation capacitance	No load,	f = 1 MHz	18	pF

5.8 Typical Characteristics

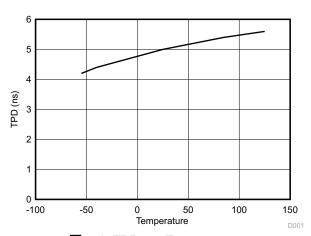
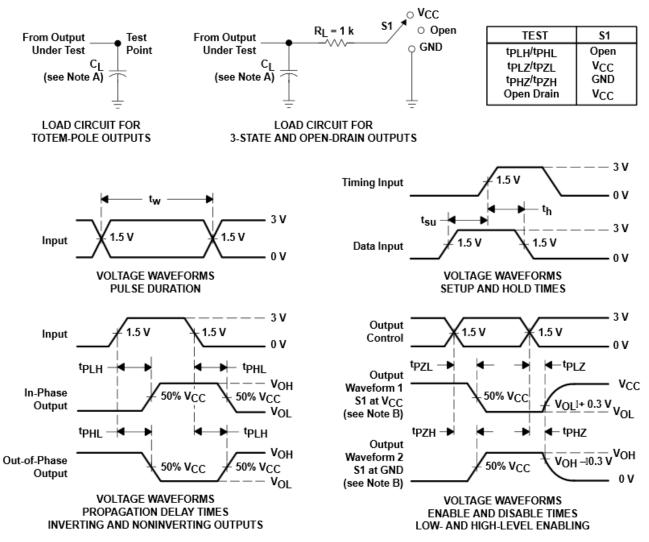


図 5-1. TPD vs. Temperature



6 Parameter Measurement Information



NOTES: A. CL includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR $^{\circ}$ 1 MHz, $Z_O = 50$, $t_\Gamma = 3$ ns, $t_\Gamma = 3$ ns.
- D. The outputs are measured one at a time with one input transition per measurement.
- E. All parameters and waveforms are not applicable to all devices.

☑ 6-1. Load Circuit and Voltage Waveforms

7 Detailed Description

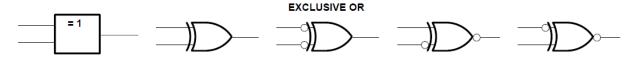
7.1 Overview

The SN74AHCT1G86 is a single 2-input exclusive-OR gate. The device performs the Boolean function $Y = A \oplus B$ or $Y = \overline{AB} + A \overline{B}$ in positive logic.

To ensure the high-impedance state during power up or power down, OE should be tied to GND through a pulldown resistor; the minimum value of the resistor is determined by the current-sourcing capability of the driver.

7.2 Functional Block Diagram

An exclusive-OR gate has many applications, some of which can be represented better by alternative logic symbols.



These five equivalent exclusive-OR symbols are valid for an SN74AHCT1G86 gate in positive logic; negation may be shown at any two ports.

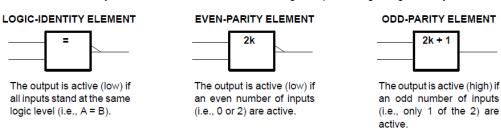


図 7-1. Exclusive-OR Logic

7.3 Feature Description

The device is ideal for operating in a 5-V logic system. The low propagation delay allows fast switching and higher speeds of operation. In addition, the low power consumption makes this device a good choice for portable and battery power-sensitive applications.

7.4 Device Functional Modes

表 7-1. Function Table

INPL	JTS ⁽¹⁾	OUTPUT ⁽²⁾
Α	В	Y
L	L	L
L	Н	Н
Н	L	Н
Н	Н	L

- (1) H = High Voltage Level, L = Low Voltage Level, X = Don't Care
- (2) H = Driving High, L = Driving Low, Z = High Impedance State

8 Application and Implementation

注

以下のアプリケーション情報は、TIの製品仕様に含まれるものではなく、TIではその正確性または完全性を保証いたしません。個々の目的に対する製品の適合性については、お客様の責任で判断していただくことになります。お客様は自身の設計実装を検証しテストすることで、システムの機能を確認する必要があります。

8.1 Application Information

The SN74AHCT1G86 is a Low drive CMOS device that can be used for a multitude of bus interface type applications where output ringing is a concern. The low drive and slow edge rates will minimize overshoot and undershoot on the outputs. The input switching levels have been lowered to accommodate TTL inputs of 0.8-V V_{IL} and 2-V V_{IH} . This feature makes it Ideal for translating up from 3.3 V to 5 V.

8.2 Typical Application

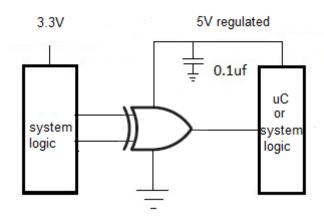


図 8-1. Typical Application Schematic

8.2.1 Design Requirements

This device uses CMOS technology and has balanced output drive. Take care to avoid bus contention because it can drive currents that would exceed maximum limits. The high drive will also create fast edges into light loads so consider routing and load conditions to prevent ringing.

8.2.2 Detailed Design Procedure

- · Recommended input conditions:
 - Rise time and fall time specs. See (Δt/ΔV) in セクション 5.3.
 - Specified high and low levels. See (V_{IH} and V_{IL}) in セクション 5.3.
- Recommended output conditions:
 - Load currents should not exceed 25 mA per output and 50 mA total for the part.
 - Outputs should not be pulled above V_{CC}.

9



8.2.3 Application Curves

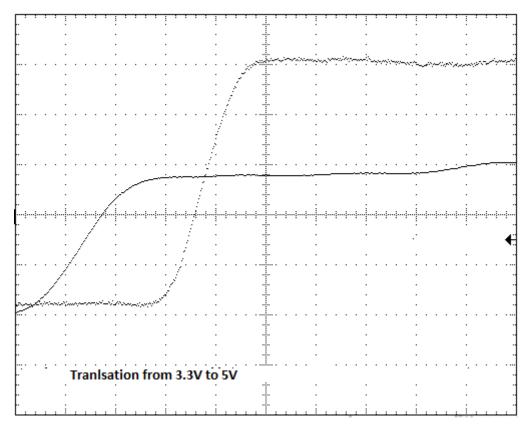


図 8-2. Translation From 3.3 V to 5.5 V

8.3 Power Supply Recommendations

The power supply can be any voltage between the minimum and maximum supply voltage rating located in the セクション 5.3.

Each V_{CC} terminal should have a good bypass capacitor to prevent power disturbance. For devices with a single supply, TI recommends a 0.1- μ F capacitor and if there are multiple V_{CC} terminals then TI recommends a 0.01- μ F or 0.022- μ F capacitor for each power terminal. Multiple bypass capacitors can be paralleled to reject different frequencies of noise. Frequencies of 0.1 μ F and 1 μ F are commonly used in parallel. The bypass capacitor should be installed as close as possible to the power terminal for best results.

8.4 Layout

8.4.1 Layout Guidelines

When using multiple bit logic devices inputs should not ever float.

In many cases, functions or parts of functions of digital logic devices are unused, for example, when only two inputs of a triple-input AND gate are used or only three of the four buffer gates are used. Such input pins should not be left unconnected because the undefined voltages at the outside connections result in undefined operational states. Specified below are the rules that must be observed under all circumstances. All unused inputs of digital logic devices must be connected to a high or low bias to prevent them from floating. The logic level that should be applied to any particular unused input depends on the function of the device. Generally they will be tied to GND or V_{CC} whichever make more sense or is more convenient. Floating outputs is generally acceptable, unless the part is a transceiver. If the transceiver has an output enable pin it will disable the outputs section of the part when asserted. This will not disable the input section of the I.O's so they also cannot float when disabled.

8.4.2 Layout Example

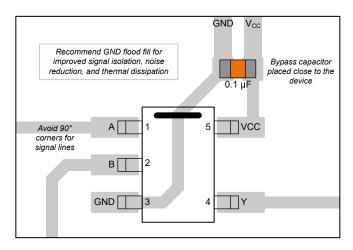


図 8-3. Layout Example for the SN74AHCT1G86

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11



9 Device and Documentation Support

9.1 Documentation Support

9.1.1 Related Documentation

For related documentation, see the following:

- Texas Instruments, CMOS Power Consumption and Cpd Calculation application note
- Texas Instruments, *Designing With Logic* application note
- Texas Instruments, Thermal Characteristics of Standard Linear and Logic (SLL) Packages and Devices application note
- Texas Instruments, Implications of Slow or Floating CMOS Inputs application note

9.2 ドキュメントの更新通知を受け取る方法

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9.6 用語集

テキサス・インスツルメンツ用語集 この用語集には、用語や略語の一覧および定義が記載されています。

10 Revision History

Changes from Revision O (October 2023) to Revision P (February 2024)

Page

Changes from Revision N (August 2022) to Revision O (October 2023)

Page

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English Data Sheet: SCLS324



11 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

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13

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PACKAGING INFORMATION

Orderable part number	Status	Material type	Package Pins	Package qty Carrier	RoHS	Lead finish/ Ball material	MSL rating/ Peak reflow	Op temp (°C)	Part marking (6)
						(4)	(5)		
74AHCT1G86DBVRG4	Active	Production	SOT-23 (DBV) 5	3000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	B86G
74AHCT1G86DBVRG4.A	Active	Production	SOT-23 (DBV) 5	3000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	B86G
74AHCT1G86DBVTG4	Obsolete	Production	SOT-23 (DBV) 5	-	-	Call TI	Call TI	-40 to 125	B86G
SN74AHCT1G86DBVR	Active	Production	SOT-23 (DBV) 5	3000 LARGE T&R	Yes	SN	Level-1-260C-UNLIM	-40 to 125	(39EH, 3CDF, B863, B86G, B86J, B 86S)
SN74AHCT1G86DBVR.A	Active	Production	SOT-23 (DBV) 5	3000 LARGE T&R	Yes	SN	Level-1-260C-UNLIM	-40 to 125	(39EH, 3CDF, B863, B86G, B86J, B 86S)
SN74AHCT1G86DBVT	Obsolete	Production	SOT-23 (DBV) 5	-	-	Call TI	Call TI	-40 to 125	(B863, B86G, B86J, B86S)
SN74AHCT1G86DCKR	Active	Production	SC70 (DCK) 5	3000 LARGE T&R	Yes	SN	Level-1-260C-UNLIM	-40 to 125	(1QV, BH3, BHG, BH J, BHL, BHS)
SN74AHCT1G86DCKR.A	Active	Production	SC70 (DCK) 5	3000 LARGE T&R	Yes	SN	Level-1-260C-UNLIM	-40 to 125	(1QV, BH3, BHG, BH J, BHL, BHS)
SN74AHCT1G86DCKT	Obsolete	Production	SC70 (DCK) 5	-	-	Call TI	Call TI	-40 to 125	(BH3, BHG, BHJ, BH S)

⁽¹⁾ Status: For more details on status, see our product life cycle.

⁽²⁾ Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

⁽³⁾ RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

⁽⁴⁾ Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

⁽⁵⁾ MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

⁽⁶⁾ Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

PACKAGE OPTION ADDENDUM

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Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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OTHER QUALIFIED VERSIONS OF SN74AHCT1G86:

Automotive: SN74AHCT1G86-Q1

NOTE: Qualified Version Definitions:

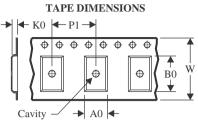
Automotive - Q100 devices qualified for high-reliability automotive applications targeting zero defects

PACKAGE MATERIALS INFORMATION

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TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE

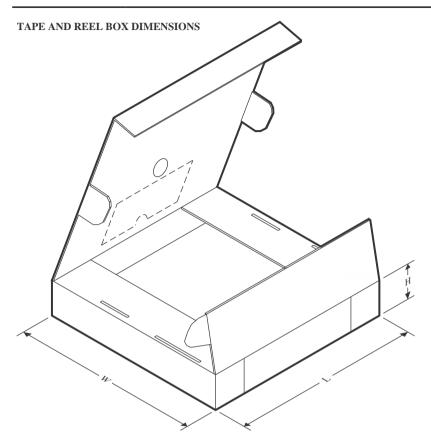


*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
74AHCT1G86DBVRG4	SOT-23	DBV	5	3000	178.0	9.0	3.23	3.17	1.37	4.0	8.0	Q3
SN74AHCT1G86DBVR	SOT-23	DBV	5	3000	180.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
SN74AHCT1G86DCKR	SC70	DCK	5	3000	180.0	8.4	2.3	2.5	1.2	4.0	8.0	Q3



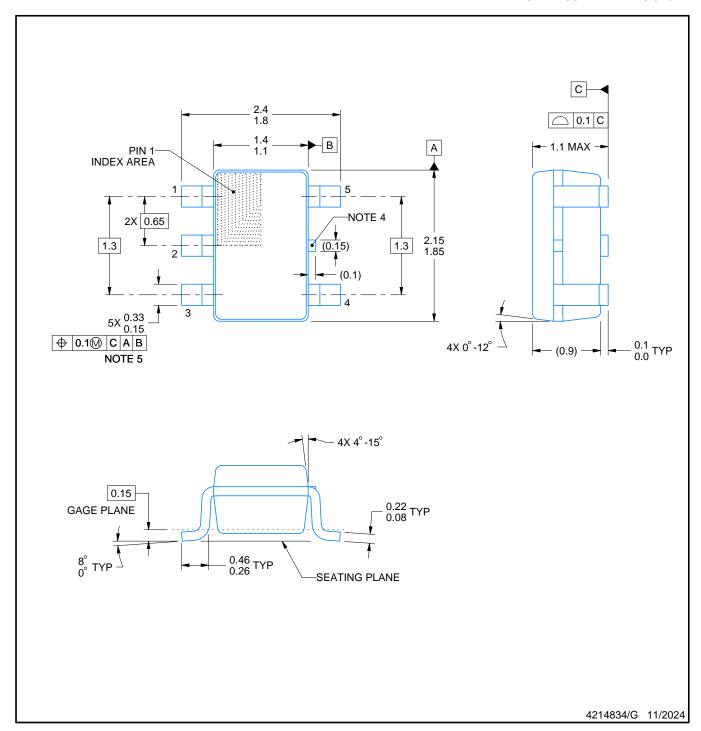
www.ti.com 18-May-2025



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
74AHCT1G86DBVRG4	SOT-23	DBV	5	3000	180.0	180.0	18.0
SN74AHCT1G86DBVR	SOT-23	DBV	5	3000	210.0	185.0	35.0
SN74AHCT1G86DCKR	SC70	DCK	5	3000	210.0	185.0	35.0



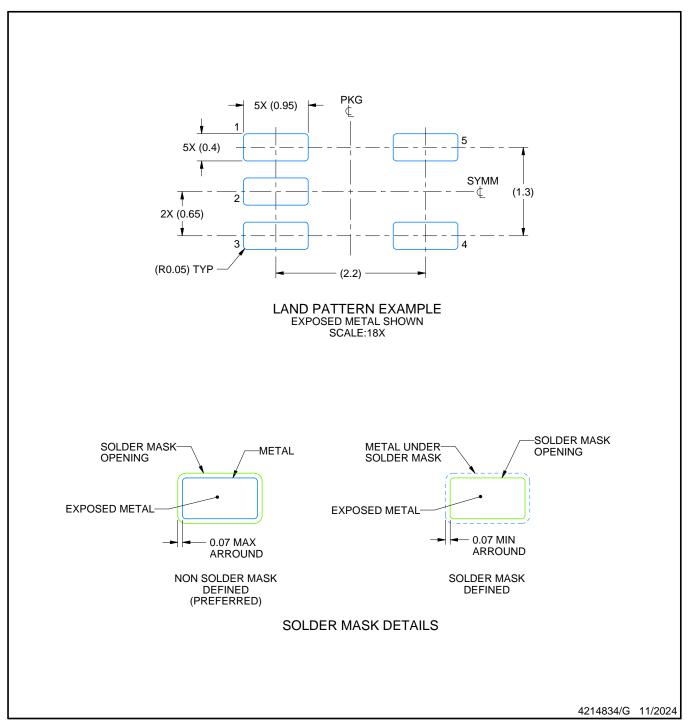


NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
 2. This drawing is subject to change without notice.
 3. Reference JEDEC MO-203.

- 4. Support pin may differ or may not be present.5. Lead width does not comply with JEDEC.
- 6. Body dimensions do not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.25mm per side

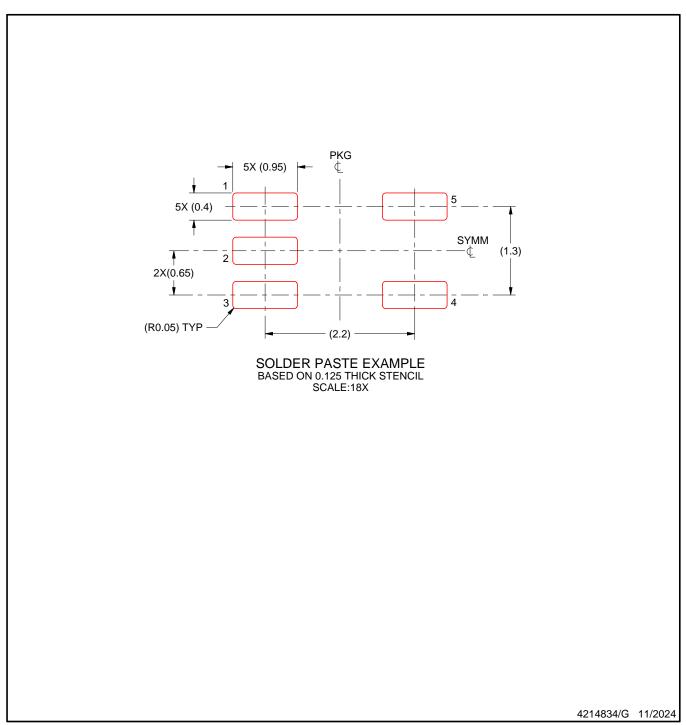




NOTES: (continued)

7. Publication IPC-7351 may have alternate designs.8. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



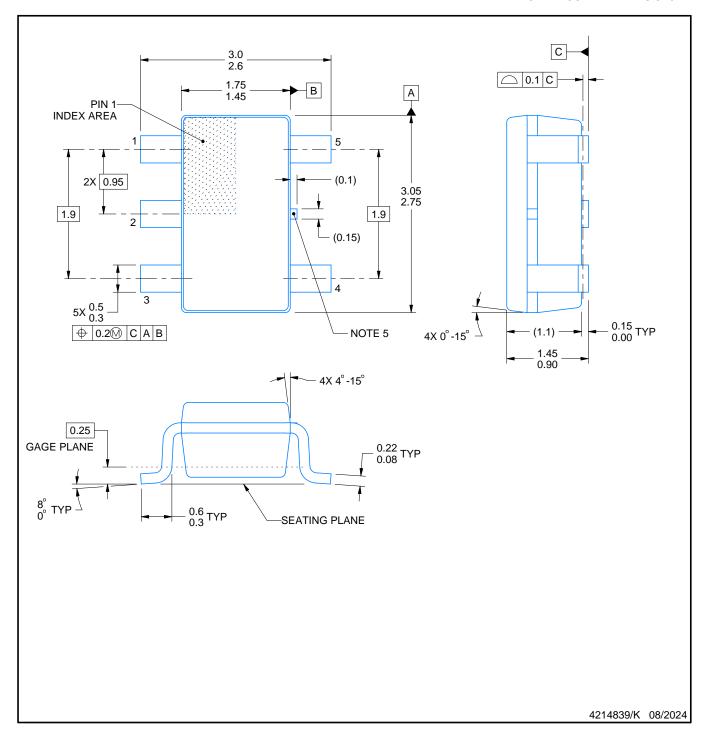


NOTES: (continued)

- 9. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 10. Board assembly site may have different recommendations for stencil design.





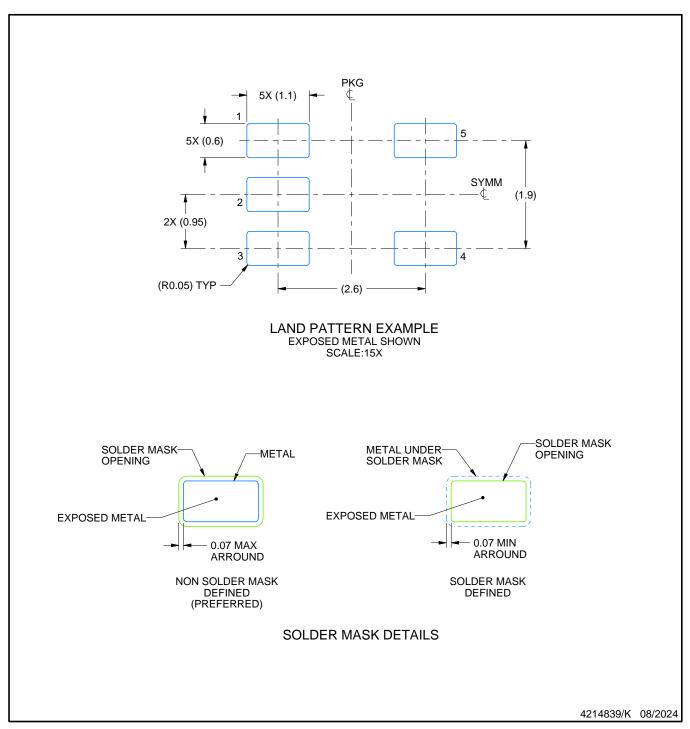


NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
 2. This drawing is subject to change without notice.
 3. Reference JEDEC MO-178.

- 4. Body dimensions do not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.25 mm per side.
- 5. Support pin may differ or may not be present.



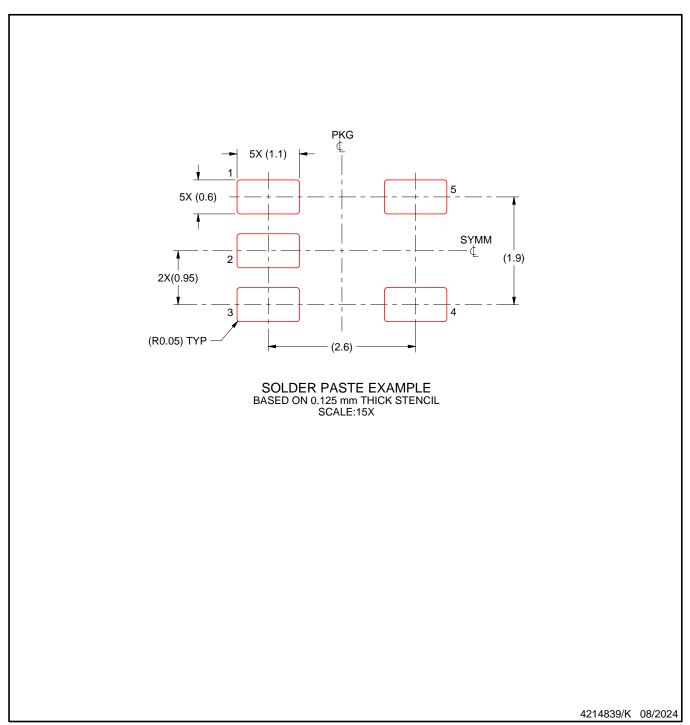


NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.





NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



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